

**Search Notes****Application/Control No.**

10/667,776

**Examiner**

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**Applicant(s)/Patent under Reexamination**

SU ET AL.

**Art Unit**

1637

**SEARCHED**

Class	Subclass	Date	Examiner
422	80	5/16/2005	
	82.01	5/16/2005	
	82.02	5/16/2005	
	82.05	5/16/2005	
435	6	5/16/2005	

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Patent Databases (USPT, USPPG, EPO, JPO, DERWENT, IBM-TDB)	5/16/2005	YJK
See enclosed for search strategy	5/16/2005	YJK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner